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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/540,190	TAN ET AL.	AN ET AL.
Examiner	Art Unit	t Unit
Kyle R. Stork	2178	78

	SEARCHED		
Class	Subclass	Date	Examiner
715	501.1, 513, 517, 523, 530	2/8/2007	1CS
725	36, 37	2/8/2007	165

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East Search (USPat, USPG-Pub)	2/8/2007 ·	ics
NPL Search	2/8/2007	103
Inventor Name Search	2/8/2007	ves
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